# MOSFET – Power, Single, N-Channel, SO-8 FL 30 V, 100 A

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Thermally Enhanced SO8 Package
- These are Pb-Free Device

#### **Applications**

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

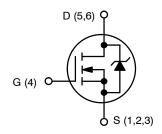
Parameter			Symbol	Value	Unit
Drain-to-Source Vo	Drain-to-Source Voltage			30	V
Gate-to-Source Vol	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>θJA</sub> (Note 1)		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I <sub>D</sub>	20.3	Α
Power Dissipation R <sub>θJA</sub> (Note 1)	1	T <sub>A</sub> = 25°C	P <sub>D</sub>	2.25	W
Continuous Drain	1	T <sub>A</sub> = 25°C	I <sub>D</sub>	32.8	Α
Current $R_{\theta JA} \leq$ 10 sec		T <sub>A</sub> = 85°C		23.7	
Power Dissipation $R_{\theta JA}$ , $t \le 10$ sec	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	5.90	W
Continuous Drain Current R <sub>θJA</sub>	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	12.7	Α
(Note 2)		T <sub>A</sub> = 85°C		9.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.89	W
Continuous Drain Current R <sub>BJC</sub>		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	100	Α
(Note 1)		T <sub>C</sub> = 85°C		72	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	55.5	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	200	Α
Current limited by package T <sub>A</sub> = 25°C		I <sub>Dmaxpkg</sub>	100	Α	
Operating Junction a Temperature	Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	–55 to +150	°C
Source Current (Boo	dy Diode)		I <sub>S</sub>	55	Α
Drain to Source dV/dt		dV/dt	6	V/ns	



## ON Semiconductor®

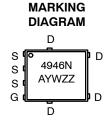
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30.1/	3.4 m $\Omega$ @ 10 V	100 A
30 V	5.1 mΩ @ 4.5 V	100 A



**N-CHANNEL MOSFET** 





A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4946NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4946NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 37 $A_{pk}$ , $L$ = 0.3 mH, $R_G$ = 25 $\Omega$ )	EAS	205	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.25	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	55.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	140.8	*C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{ hetaJA}$	21.2	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** (T.I = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				25		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			1	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.45	1.8	2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V to 11.5 V V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		2.5	3.4	
			I <sub>D</sub> = 15 A		2.4		
			I <sub>D</sub> = 30 A		3.8	5.1	mΩ
			I <sub>D</sub> = 15 A		3.8		
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 30 A			85		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				3250		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 12 V			562		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				289		
Total Gate Charge	$Q_{G(TOT)}$				21.8	32	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V 45VV	15 \\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		3.2		0
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 3.5 \text{ V}$	15 V; I <sub>D</sub> = 30 A		8.1		nC
Gate-to-Drain Charge	$Q_{GD}$	1			7.4		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 30 A			53		nC
SWITCHING CHARACTERISTICS (Note 4)							-
Turn-On Delay Time	t <sub>d(ON)</sub>				18.9		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 1	5 V, I <sub>D</sub> = 15 A.		34		1
	1	$R_{G} = 3.0 \Omega$					ns

- 3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 4. Switching characteristics are independent of operating junction temperatures.

Fall Time

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>				10.7		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			18.9		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				34.2		
Fall Time	t <sub>f</sub>				7.1		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$		8.0	1.0	V	
			T <sub>J</sub> = 125°C		0.66		7 °
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/μs, I <sub>S</sub> = 30 A			21.6		ns
Charge Time	t <sub>a</sub>				11.4		
Discharge Time	t <sub>b</sub>				10.2		
Reverse Recovery Charge	Q <sub>RR</sub>				8.5		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.65		nΗ
Drain Inductance	L <sub>D</sub>				0.005		
Gate Inductance	L <sub>G</sub>				1.84		
Gate Resistance	$R_{G}$			0.5	1.4	2.2	Ω

<sup>3.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

## **TYPICAL CHARACTERISTICS**

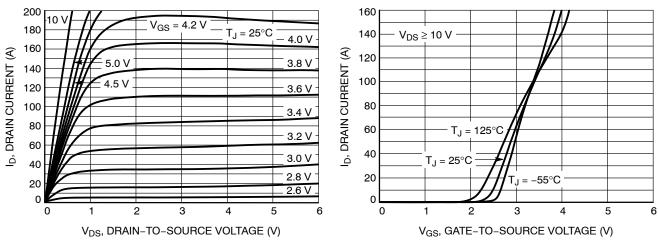
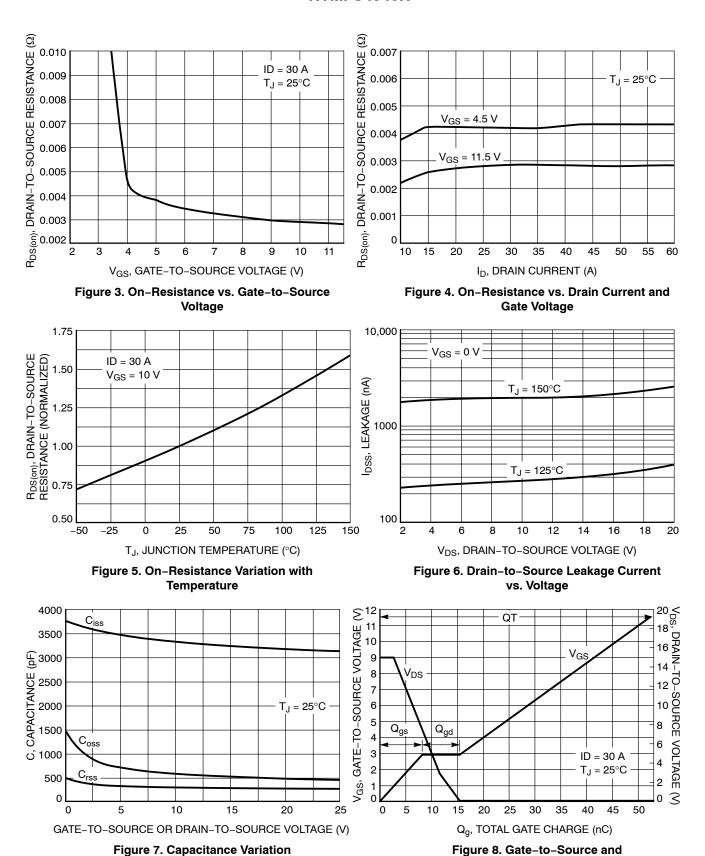


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

## **TYPICAL CHARACTERISTICS**

<sup>4.</sup> Switching characteristics are independent of operating junction temperatures.



Drain-to-Source Voltage vs. Total Charge

#### **TYPICAL CHARACTERISTICS**

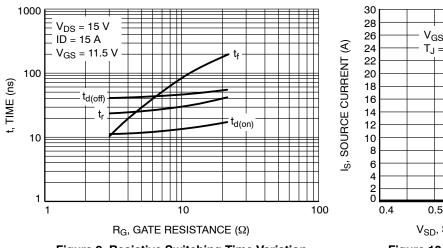


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

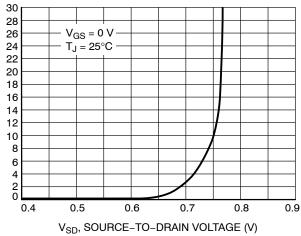


Figure 10. Diode Forward Voltage vs. Current

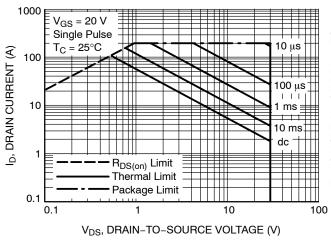
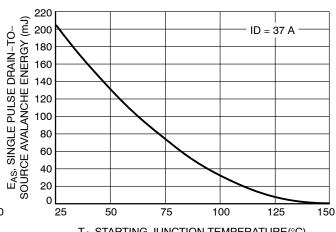


Figure 11. Maximum Rated Forward Biased



TJ, STARTING JUNCTION TEMPERATURE (°C)

Safe Operating Area

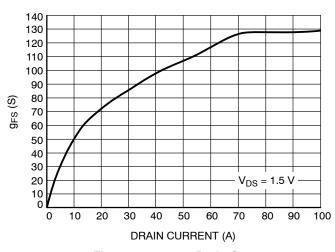


Figure 13. g<sub>FS</sub> vs. Drain Current



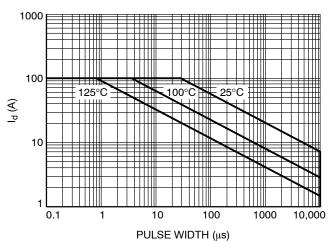


Figure 14. I<sub>d</sub> vs. Pulse Width

SCALE 2:1

0.10

0.10

SIDE VIEW



DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

#### **DATE 25 JUN 2018**

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC	;			
G	0.51	0.575	0.71			
K	1.20	1.35	1.50			
L	0.51	0.575	0.71			
L1	0.125 REF					
М	3.00	3.40	3.80			
θ	0 °		12 °			

#### **GENERIC MARKING DIAGRAM\***



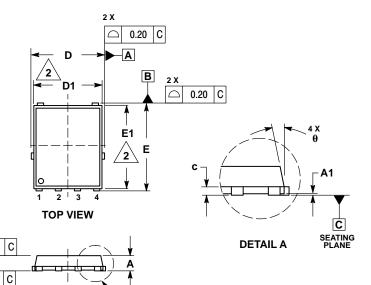
XXXXXX = Specific Device Code

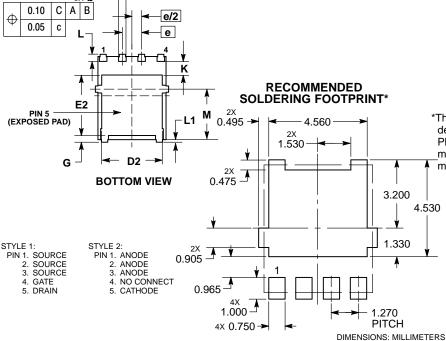
= Assembly Location Α

Υ = Year W = Work Week

ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON14036D	Electronic versions are uncontrolled except when accessed directly from the Document Report Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ÓN Semiconductor does not convey any license under its patent rights nor the rights of others

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

## PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

**TECHNICAL SUPPORT** North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative